TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3471

Switching Regulator and DC-DC Converter Applications

• Low drain-source ON resistance: $RDS(ON) = 10 \Omega(typ.)$

High forward transfer admittance: $|Y_{fs}| = 0.4 \text{ S (typ.)}$

Low leakage current: $IDSS = 100 \mu A (max) (VDS = 500 V)$

Enhancement-model: $V_{th} = 2.0$ to 4.0 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	500	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	500	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	I _D	0.5	А
	Pulse (Note 1)	I _{DP}	1.5	A
Drain power dissipation	1	P _D	0.5	W
Drain power dissipation	n (Note 2)	P _D	1.5	W
Single pulse avalanche energy (Note 3)		E _{AS}	14.3	mJ
Avalanche current		I _{AR}	0.5	Α
Repetitive avalanche energy (Note 4)		E _{AR}	0.05	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55 to150	°C

Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient	R _{th (ch-a)}	250	°C/W	

Note 1: Please use devices on condition that the channel temperature is below 150°C.

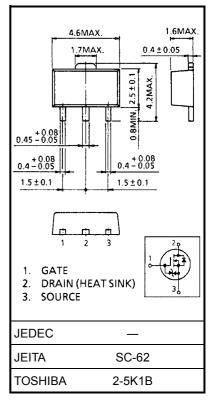
Note 2: Mounted on ceramic substrate (25.4 mm \times 25.4 mm \times 0.8 mm)

Note 3: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 100 mH, $R_G = 25 \Omega$, $I_{AR} = 100 \text{ mH}$ 0.5 A

Note 4: Repetitive rating: Pulse width limited by maximum channel temperature

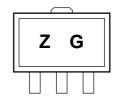
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm



Weight: 0.05 g (typ.)





(The two digits represent the part number.)



Electrical Characteristics (Ta = 25°C)

Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain-source brea	kdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-OFF cur	rent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source brea	kdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	500	_	_	V
Gate threshold voltage		V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON I	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 0.25 A		10	18	Ω
Forward transfer a	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 0.25 A	0.2	0.4	_	S
Input capacitance		C _{iss}		_	75	_	
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	7	_	pF
Output capacitance		Coss		_	24	_	
Switching time	Rise time	t _r	$V_{GS} = 0.25 \text{ A} \\ V_{GS} = 0.25 \text{ A} \\ V_{DUT} = 0.25 \text{ A} \\ V_{OUT} = 0.25 \text{ A} \\$	_	11	_	ns
	Turn-ON time	t _{on}		_	18	_	
	Fall time	t _f			54		115
	Turn-OFF time	t _{off}			95		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.5 \text{ A}$	_	3.8	_	nC
Gate-source charge		Q _{gs}		_	1.9	_	
Gate-drain ("miller") charge		Q _{gd}			1.9	_	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	0.5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	1.5	Α
Forward voltage (diode)	V_{DSF}	$I_{DR} = 0.5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 0.5 \text{ A}, V_{GS} = 0 \text{ V},$	_	190	_	ns
Reverse recovery charge	Qrr	dI _{DR} /dt = 100 A/μs	_	380		nC

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